



ALPHA & OMEGA
SEMICONDUCTOR

AOD3N60/AOU3N60

600V, 2.5A N-Channel MOSFET

General Description

The AOD3N60 & AOU3N60 have been fabricated using an advanced high voltage MOSFET process that is designed to deliver high levels of performance and robustness in popular AC-DC applications. By providing low $R_{DS(on)}$, C_{iss} and C_{rss} along with guaranteed avalanche capability these parts can be adopted quickly into new and existing offline power supply designs.

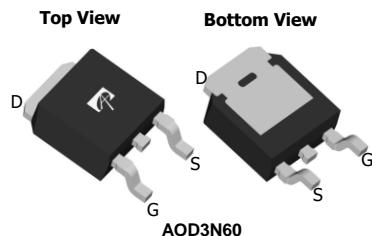
Product Summary

| | |
|---------------------------------|------------|
| V_{DS} | 700V@150°C |
| I_D (at $V_{GS}=10V$) | 2.5A |
| $R_{DS(ON)}$ (at $V_{GS}=10V$) | < 3.5Ω |

100% UIS Tested!
100% R_g Tested!



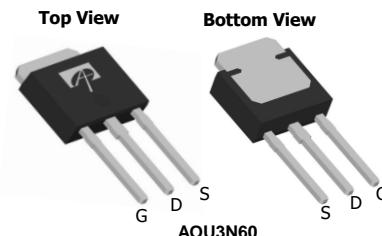
TO252
DPAK



Top View

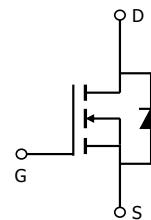
Bottom View

TO251



Top View

Bottom View



Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter | Symbol | Maximum | Units |
|--|----------------|------------|-------|
| Drain-Source Voltage | V_{DS} | 600 | V |
| Gate-Source Voltage | V_{GS} | ± 30 | V |
| Continuous Drain Current ^B | I_D | 2.5 | A |
| $T_C=100^\circ C$ | | 1.6 | |
| Pulsed Drain Current ^C | I_{DM} | 8 | |
| Avalanche Current ^C | I_{AR} | 2 | A |
| Repetitive avalanche energy ^C | E_{AR} | 60 | mJ |
| Single pulsed avalanche energy ^H | E_{AS} | 120 | mJ |
| Peak diode recovery dv/dt | dv/dt | 5 | V/ns |
| Power Dissipation ^B | P_D | 56.8 | W |
| $T_C=25^\circ C$ | | 0.45 | W/°C |
| Junction and Storage Temperature Range | T_J, T_{STG} | -50 to 150 | °C |
| Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds | T_L | 300 | °C |

Thermal Characteristics

| Parameter | Symbol | Typical | Maximum | Units |
|--|-----------------|---------|---------|-------|
| Maximum Junction-to-Ambient ^{A,G} | $R_{\theta JA}$ | 45 | 55 | °C/W |
| Maximum Case-to-sink ^A | $R_{\theta CS}$ | - | 0.5 | °C/W |
| Maximum Junction-to-Case ^{D,F} | $R_{\theta JC}$ | 1.8 | 2.2 | °C/W |

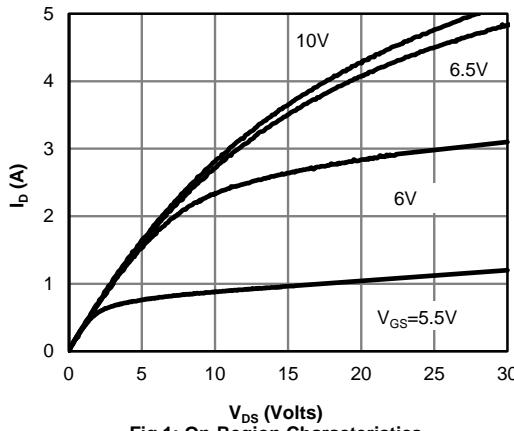
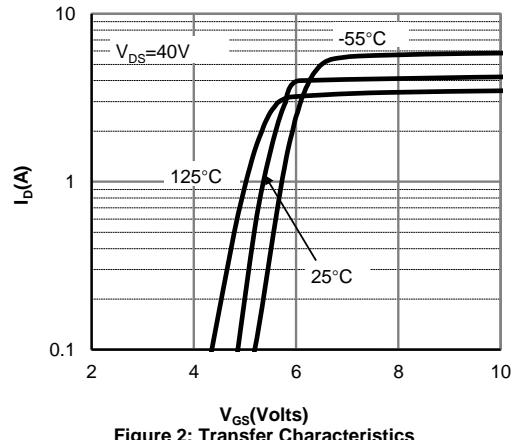
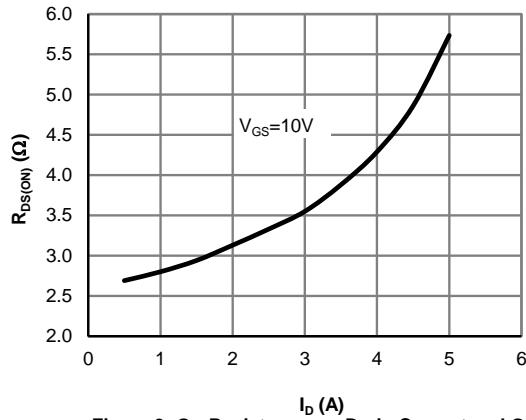
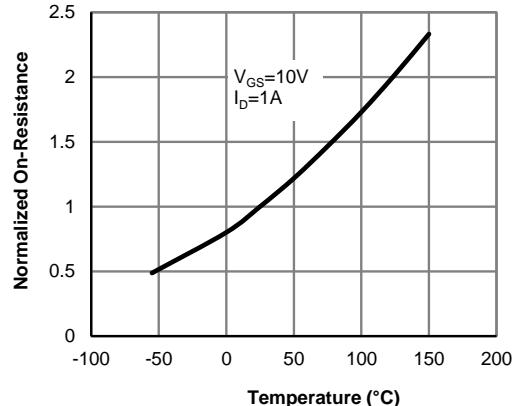
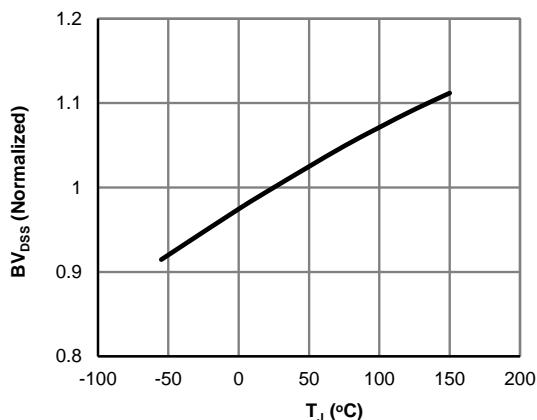
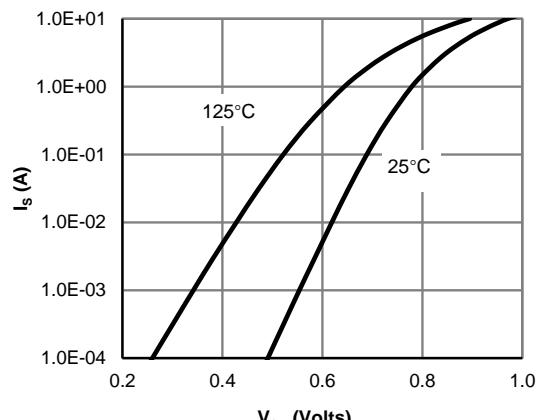
Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

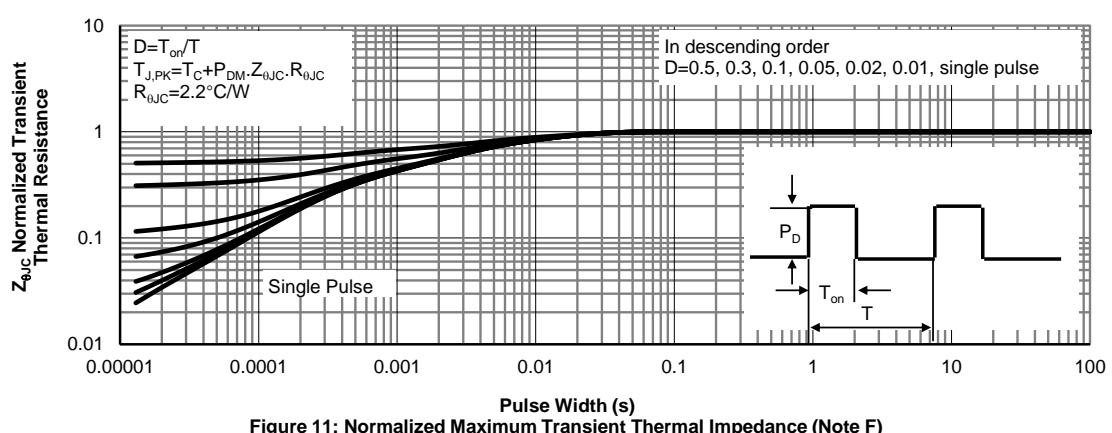
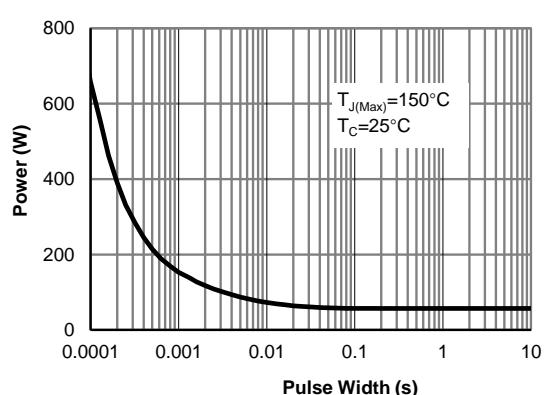
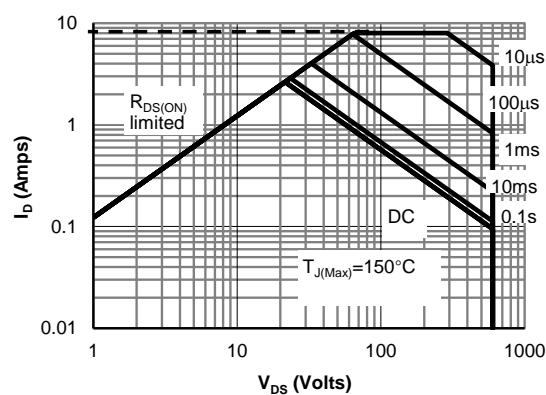
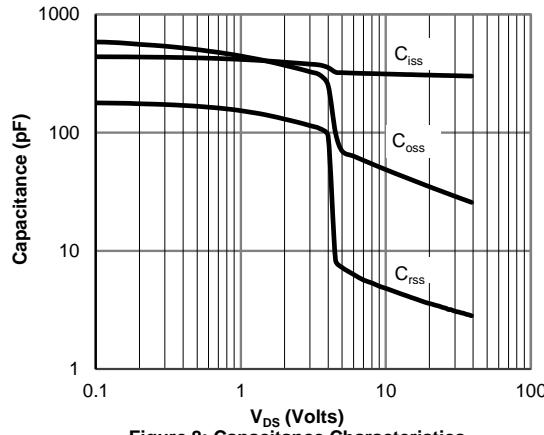
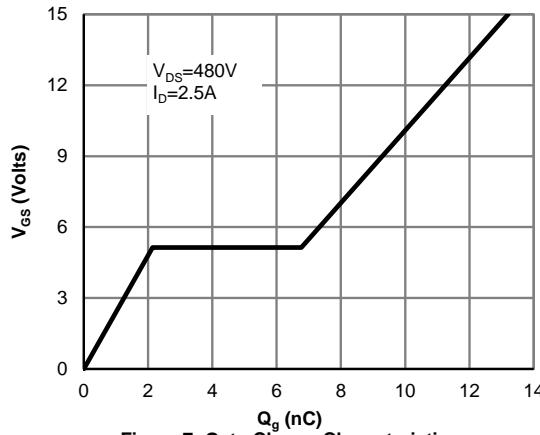
| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|------------------------------------|---------------------------------------|---|-----|------|------|-------|
| STATIC PARAMETERS | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | I _D =250μA, V _{GS} =0V, T _J =25°C | 600 | | | V |
| | | I _D =250μA, V _{GS} =0V, T _J =150°C | | 700 | | |
| BV _{DSS} /ΔT _J | Zero Gate Voltage Drain Current | I _D =250μA, V _{GS} =0V | | 0.65 | | V/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} =600V, V _{GS} =0V | | | 1 | μA |
| | | V _{DS} =480V, T _J =125°C | | | 10 | |
| I _{GSS} | Gate-Body leakage current | V _{DS} =0V, V _{GS} =±30V | | | ±100 | nA |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} =5V I _D =250μA | 3 | 4 | 4.5 | V |
| R _{DS(ON)} | Static Drain-Source On-Resistance | V _{GS} =10V, I _D =1.25A | | 2.9 | 3.5 | Ω |
| g _{FS} | Forward Transconductance | V _{DS} =40V, I _D =1.25A | | 2.8 | | S |
| V _{SD} | Diode Forward Voltage | I _S =1A, V _{GS} =0V | | 0.64 | 1 | V |
| I _S | Maximum Body-Diode Continuous Current | | | | 2 | A |
| I _{SM} | Maximum Body-Diode Pulsed Current | | | | 8 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C _{iss} | Input Capacitance | V _{GS} =0V, V _{DS} =25V, f=1MHz | 240 | 304 | 370 | pF |
| C _{oss} | Output Capacitance | | 25 | 31.4 | 38 | pF |
| C _{rss} | Reverse Transfer Capacitance | | 2.6 | 3.3 | 4 | pF |
| R _g | Gate resistance | V _{GS} =0V, V _{DS} =0V, f=1MHz | 2.3 | 2.9 | 6 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| Q _g | Total Gate Charge | V _{GS} =10V, V _{DS} =480V, I _D =2.5A | | 9.9 | 12 | nC |
| Q _{gs} | Gate Source Charge | | | 2.1 | 3 | nC |
| Q _{gd} | Gate Drain Charge | | | 4.6 | 6 | nC |
| t _{D(on)} | Turn-On DelayTime | V _{GS} =10V, V _{DS} =300V, I _D =2.5A, R _G =25Ω | | 17 | 20 | ns |
| t _r | Turn-On Rise Time | | | 17 | 20 | ns |
| t _{D(off)} | Turn-Off DelayTime | | | 24 | 30 | ns |
| t _f | Turn-Off Fall Time | | | 16 | 20 | ns |
| t _{rr} | Body Diode Reverse Recovery Time | I _F =2.5A,dI/dt=100A/μs,V _{DS} =100V | | 175 | 210 | ns |
| Q _{rr} | Body Diode Reverse Recovery Charge | I _F =2.5A,dI/dt=100A/μs,V _{DS} =100V | | 1.4 | 1.7 | μC |

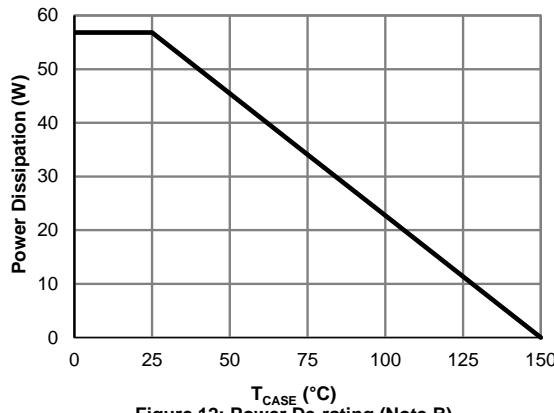
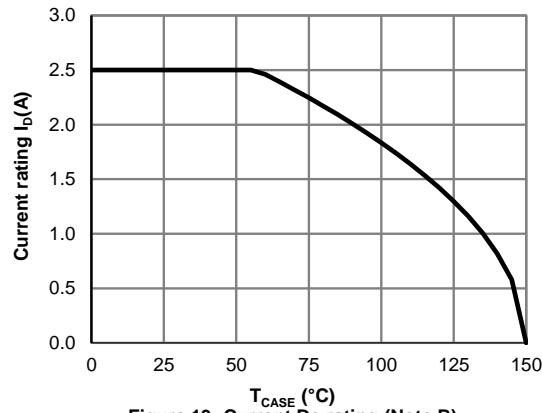
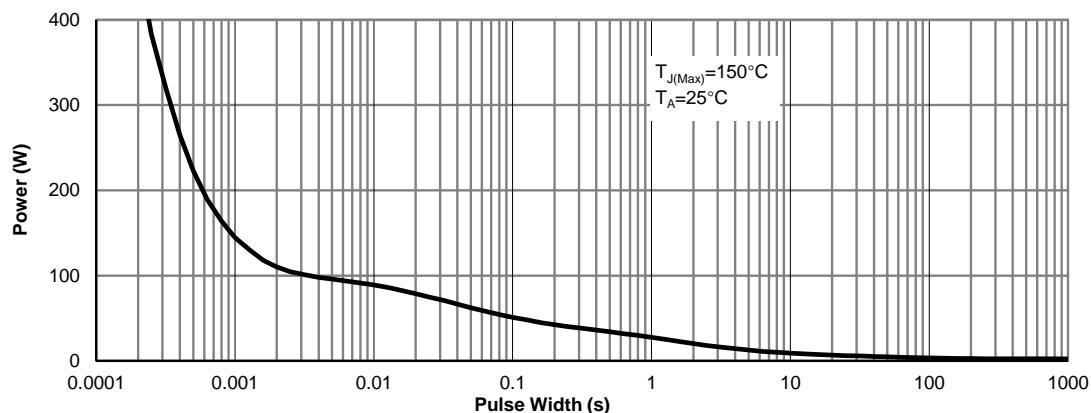
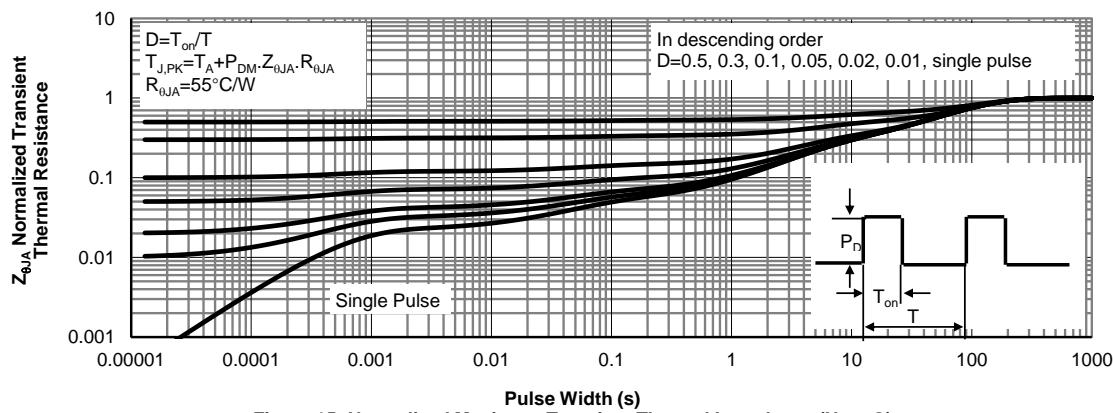
- A. The value of R_{θJA} is measured with the device in a still air environment with T_A=25°C.
B. The power dissipation P_D is based on T_{J(MAX)}=150°C in a TO252 package, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150°C.
D. The R_{θJA} is the sum of the thermal impedance from junction to case R_{θJC} and case to ambient.
E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150°C.
G. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C.
H. L=60mH, I_{AS}=2A, V_{DD}=150V, R_G=10Ω, Starting T_J=25°C

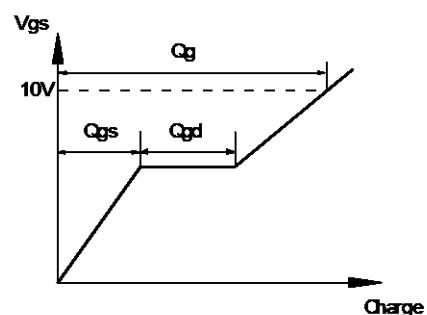
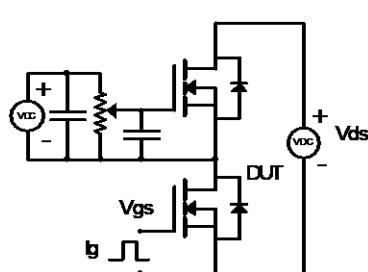
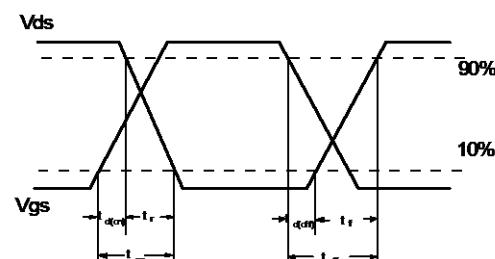
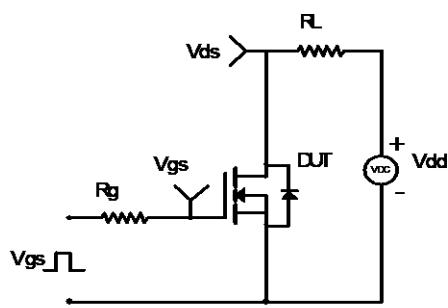
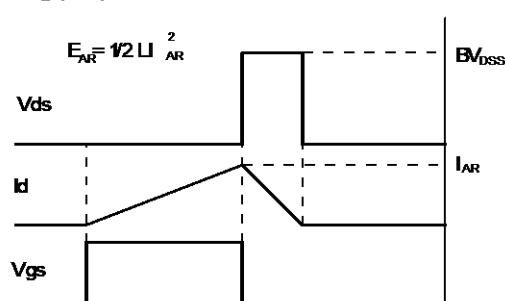
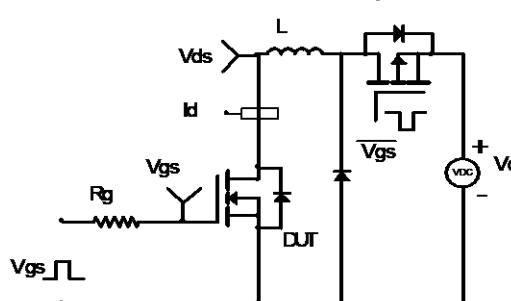
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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Fig 1: On-Region Characteristics

Figure 2: Transfer Characteristics

Figure 3: On-Resistance vs. Drain Current and Gate Voltage

Figure 4: On-Resistance vs. Junction Temperature

Figure 5: Break Down vs. Junction Temperature

Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS


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Figure 12: Power De-rating (Note B)

Figure 13: Current De-rating (Note B)

Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note G)

Figure 15: Normalized Maximum Transient Thermal Impedance (Note G)

Gate Charge Test Circuit & Waveform

Resistive Switching Test Circuit & Waveforms

Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

Diode Recovery Test Circuit & Waveforms
